Cross-section measurement for the ggF, H→WW* at ATLAS

Dongshuo Du

Shandong University

CLHCP2020, 2020/11/6





Outline

- Analysis overview
- Definition of signal regions and control regions
- Fake background estimation
- Statistical fit results
- Summary

Analysis overview



- Only select different flavour ($e\mu + \mu e$) opposite charge leptons in the final states.
- Classified by the number of jets(0/1).
- Main backgrounds:
 - WW .

- top
- NonWW diboson
- Wjets Ztautau

Channel	qqWW	Тор	Z/γ^*	VV other than <i>qqWW</i>	W + jets
$N_{\rm jet} = 0$	CR	CR	CR	MC+VR	Data
$N_{\rm jet} = 1$	CR	CR	CR	MC+VR	Data



2

n_{jet}

Signal region definition



The definition of signal regions and control regions are based on the preselection

m_T [GeV]

WW control region

250

m_T [GeV]

200





- The cuts are used to orthogonal to the SRs
- Purity in control region
 - 67% for 0jet
 - 34% for 1 jet
- Normalization factors (*)
 - ➤ 1.10 +/- 0.01 (stat.) 0jet
 - ➤ 0.89 +/- 0.02 (stat.) 1 jet

(*) NFs are calculated by using simple 3x3 matrix inversion method

Top pt reweighting

- Lepton pT mismodelling observed in top backgrounds
- Reweighting method:
 - Ttbar NNLO reweighting: correction from NLO QCD to NNLO
 - ✓ Used as baseline in this analysis.

Lepton pt reweighting: in-situ correction of leading lepton pt

Reweighting function:

(Data - otherBkg -sig)/top









Top control region



The cuts are used to orthogonal to the SRs

- Purity in control region
 - 89% for 0jet
 - 98% for 1jet
- Normalization factors (*)
 - ➤ 1.03 +/- 0.01 (stat.) 0jet
 - ➤ 1.02 +/- 0.01 (stat.) 1 jet

(*) NFs are calculated by using simple 3x3 matrix inversion method

Z→ττ control region



- Purity in control region
 - 94% for 0jet
 - 76% for 1jet
- Normalization factors (*)
 - 0.95 +/- 0.01 (stat.) 0jet
 0.90 +/- 0.01 (stat.) 1 jet

The cuts are used to orthogonal to the SRs

(*) NFs are calculated by using simple 3x3 matrix inversion method

W+jets: Fake factor method

- Due to poor MC modeling, W+jets background estimated in a data driven way using fake factor method.
- Three ingredients: W+jets control sample, fake factor and flavour correction.

 $N_{\text{anti-id}}(\mathbf{p}_T, \eta)$

$$N_{id+id}^{W+jets} = N_{id+anti-id}^{W+jets} \times FF \times CF = \left(N_{id+anti-id} - N_{id+anti-id}^{EW}\right) \times FF \times CF$$
where the fake factor and the flavour correction factors defined as
$$FF(p_T, \eta) = \frac{N_{id}(p_T, \eta)}{N_{anti-id}(p_T, \eta)}; CF = \left[\frac{FF(W+jets)}{FF(Z+jets)}\right]_{MC}$$

- Fake factor derived in Z+jets control sample with dedicated "3-lepton" selection in which 2 leptons are "Z-tagged" and an additional "fake candidate" lepton.
- CF corrects for the different flavour compositions in W+jet(CR) and Z+jets(FF).





electro

muor

Vgamma validation region

- The definition:
 - Same definition as SR except for lepton charge(Same Sign).
 - Only single-muon trigger.
 - Release author and BLayerRequirement for electron id requirement to enrich the fakes from photons.
- Fake factors and correction factors are re-derived specific for Vgamma VR, use the same method as previous slides.





Fit setup

• Perform binned profile likelihood fit to extract signal strength μ_{ggF} :



- mT used as discriminant variable in the final fit.
 - ➤ [80-130] GeV considered, outside as over/under-flow.
- 8 signal regions:

N_{j}	$m_{\ell\ell}$	$p_{\mathrm{T}}^{\mathrm{sublead}}$
$N_{\rm jet} = 0$	[10-30, 30-55]	[15-20, 20-∞]
$N_{\rm jet} = 1$	[10-30, 30-55]	[15-20, 20-∞]



- Optimize the sensitivity by re-mapping the MT distribution
 - [<90, 90–100, 100–110, 110–120, 120–130, >130] GeV for both 0 and 1jet

Systematics uncertainties

- Theory uncertainties:
 - > ggF signal: ggF jet bin migration, α s, shower
 - ➤ VBF: scale, shower, pdf, matching
 - > WW: αs, pdf, scale, QSF,CSSKIN , ckkw (truth level),ggWW scale
 - Top: Interference (Wt only), matching, shower, scale, ISR, FSR, pdf
 - ZTT: generator, pdf, scale, αs
- Experimental uncertainties follow the ATLAS recommendation:
 - > Trigger
 - Pileup reweighting
 - ≻ MET
 - Electron and muon related

- ≻ Jet
- Flavour tagging
- Luminosity

Expected fit results



• Sensitivity:

 $\mu_{ggF} = 1.000^{+0.158}_{-0.144}$

 $=1.000_{-0.050}^{+0.051} (\text{Data Stat})_{-0.044}^{+0.047} (MC \text{ Stat})_{-0.089}^{+0.100} (Exp)_{-0.094}^{+0.109} (Theo)$

• Significance:

8.3

- Only top 40 are shown
- No large constraints
- Use independent framework to reprodcue and validated the fit results

Δû

Combined fit results(ggF+VBF)

- Perform ggF + VBF combined fit.
- Expected sensitivity:



Summary

- Presented the full Run 2 H \rightarrow WW* analysis.
 - ➢ ggF 0/1 jet fit result:

 $\mu_{ggF} = 1.000^{+0.158}_{-0.144}$

• ggF+VBF combined fit results:

 $\mu_{ggF} = 1.000^{+0.147}_{-0.137}$ $\mu_{VBF} = 1.000^{+0.252}_{-0.209}$

• Aiming to publish before Moriond 2021.

Back-up

Event preselection

- Preselection:
 - Exactly two opposite-charge , different-flavour (e,µ) leptons.
 - $p_T^{Lead} > 22 GeV, p_T^{Sublead} > 15 GeV$
 - $m_{ll} > 10 GeV$
 - $p_T^{miss} > 20 GeV$
- The defination of Signal regions and control regions are based on the preselection

Triggers used in this analysis:

An OR combination of unprescaled single lepton and dilepton triggers.

•	Lepton	Level-1 Trigger	High Level Trigger
		2	015
8		$\begin{array}{c c} epton & Level-1 \ Trigger \\ \hline 20 \\ \hline 20 \\ \hline 20 \\ \hline 20 \\ \hline e \\ \hline & L1_EM20VH \\ \hline L1_EM22VHI \\ \hline & L1_EM22VHI \\ \hline \\ \mu \\ \hline & L1_EM15VH_MU10 \\ \hline \\ \hline & 2016 \\ \hline \\ e \\ \hline & L1_EM22VHI \\ \hline \\ & L1_EM2VHI \\ \hline \\ \\ & L1_EM2VHI \\ \hline \\ & L1_EM2VHI \\ \hline \\ \\ & L1_EM2$	HLT_e24_lhmedium_L1EM20VH
	е	L1_EM22VHI	HLT_e60_lhmedium
		L1_EM22VHI	HLT_e120_lhloose
		L1_MU15	HLT_mu20_iloose_L1MU15
	μ	L1_MU20	HLT_mu50
	eμ	L1_EM15VH_MU10	HLT_e17_lhloose_mu14
	2 2	2016	5-2018
		L1_EM22VHI	HLT_e26_lhtight_nod0_ivarloose
	е	L1_EM22VHI	HLT_e60_lhmedium_nod0
		L1_EM22VHI	HLT_e140_lhloose_nod0
		L1_MU20, L1_MU21	HLT_mu26_ivarmedium
	μ	L1_MU20, L1_MU21	HLT_mu50
- 2	eμ	L1_EM15VH_MU10	HLT_e17_lhloose_nod0_mu14

MC samples

Process	Generator	σ .Br(pb)	Precision $\sigma_{incl.}$
$ggF H \rightarrow WW$	POWHEG+ Pythia8	10.4	N ³ LO+NNLL
$VBF H \rightarrow WW$	POWHEG+ Pythia8	0.808	NNLO
$WH H \rightarrow WW$	POWHEG +PYTHIA 8 (MINLO)	0.293	NNLO
$ZH H \rightarrow WW$	Powheg +Pythia 8 (MINLO)	0.189	NNLO
inclusive $Z/\gamma^* \rightarrow \ell\ell \ (40 \ge m_{\ell\ell} \ge 10 \text{GeV})$	Sherpa 2.2.1	6.80×10^{3}	NNLO
inclusive $Z/\gamma^* \to \ell\ell \ (m_{\ell\ell} \ge 40 \text{GeV})$	SHERPA 2.2.1	2.107×10^{3}	NNLO
$(W \to \ell \nu) \gamma$	SHERPA 2.2.8	453	NLO
$(Z \to \ell \ell) \gamma$	SHERPA 2.2.8	175	NLO
$t\bar{t}$ di-leptonic(e, μ , τ)	POWHEG+Pythia8	76.96	NNLO+NNLL
Wt leptonic	POWHEG+Pythia8	6.99	NLO
$q\bar{q}/g \rightarrow WW \rightarrow \ell \nu \ell \nu$	SHERPA 2.2.2	12.5	NNLO
$qq \rightarrow WWqq \rightarrow \ell \nu \ell \nu j j$	SHERPA 2.2.2	0.095	NNLO
$Z^{(*)}Z^{(*)} \to 2\ell 2\nu$	SHERPA 2.1	6.53	NLO
$gg \rightarrow WW \rightarrow 2\ell 2\nu$	Sherpa 2.2.2	0.47	NLO
$q\bar{q}/g \rightarrow \ell \nu \ell \ell$	SHERPA 2.2.2	2.98	NNLO
$q\bar{q}/g, gg \rightarrow \ell\ell\ell\ell$	SHERPA 2.2.2	1.269	NNLO

Back

NFs calculation

(simple 3x3 matrix inversion method)

Calculate the value of NFs: •

Num WW ZttCR: the number of WW events in Ztt CR Num Top ZttCR: the number of Top events in Ztt CR Num Ziet ZttCR: the number of Ziets events in Ztt CR

Num WW TopCR: the number of WW events in Top CR Num Top TopCR: the number of Top events in Top CR Num Zjet TopCR: the number of Zjets events in Top CR

Num WW WWCR: the number of WW events in WW CR Num Top WWCR: the number of Top events in WW CR Num Zjet WWCR: the number of Zjets events in WW CR

(Num_WW_ZttCR	Num_Top_ZttCR	Num_Zjet_ZttCR `) (NF_	_ <i>WW</i> `) (data _	$_Z$ tt <i>CR</i>
Num_WW_TopCR	Num_Top_TopCR	Num_Zjet_TopCR	×	NF	_Top	=	data_	TopCR
Num_WW_WWCR	Num_Top_WWCR	Num_Zjet_WWCR		NF_	Zjets		data_	WWCR

The NF for each sample can be calculated by the 3-dimensional matrix.

NF uncertainties and correlations are computed by using toys. ۲ The toy NFs are created by randomly varying input counters (data and MC) according to a

gaussian distribution using the uncertainties of the input quantities.

Fake backgrounds

- Jets misidentified as leptons
 - Mainly come from Wjets
- Non-negligible background in the analysis
 - Mainly contributed to the low pt region
 - Hard to reduce by using kinematic selection cut
- Due to poor MC modeling, data driven fake factor method are chosen.
 - Estimate in W+jets CR where a single lepton is "anti-identified".
 - The anti-ID events are extrapolated to the SR by fake factor.





p^{l1} [GeV]

W+jets Control region

- The defination of W+jets CR is the same as SR but with one lepton satisfing ID requirement and another satisfing a looser anti-ID requirement
 - > 4 region in total(0,1×e/ μ fake)
- Fake yields are determined by subtracting prompt contribution from data in Wjets CR.
- The contribution of fake in the SRs are determined by the fake yield in Wjets CR and fake factor.

$$N_{>0 \text{ fakes}}^{i,i} = F_2(N^{i,a} - N_2^{i,a}) + F_1(N^{a,i} - N_2^{a,i}) - F_1F_2(N^{a,a} - N_2^{a,a}).$$

$$F_1: \text{ FF of } 1^{\text{st}} \text{ lep (e)}$$

$$F_2: \text{ FF of } 2^{\text{nd}} \text{ lep (\mu)}$$

i = id, a = anti-id



Elec	etron	M	uon
identified	anti-identified	identified	anti-identified
$p_{\rm T} > 1$	5 GeV	<i>p</i> _T >	15 GeV
$ \eta < 2.47$, excluding	$g 1.37 < \eta < 1.52$	$ \eta $	< 2.5
$ z_0 \sin \theta $	< 0.5 mm	$ z_0 \sin \theta $	< 0.5 mm
$ d_0 /\sigma($	$(d_0) < 5$	$ d_0 /\sigma(d_0) < 3$	$ d_0 /\sigma(d_0) < 15$
Pass LHTight if $p_{\rm T} < 25$ GeV Pass LHMedium if $p_{\rm T} > 25$ GeV	Pass LHLoose	Pass Quality Tight	Pass Quality Medium
Pass FCTight isolation		Pass FCTight isolation	
Autho	DR = 1		
	Veto against identified		Veto against identified

Fake factor extrapolation

 Fake factor derived in Z+jets control sample with dedicated "3-lepton" selection in which 2 leptons are "Z-tagged" and an additional "fake candidate" lepton.

$$F = \frac{N_{data}^{i,i,i} - N_{non-Z+jets,MC}^{i,i,i}}{N_{data}^{i,i,a} - N_{non-Z+jets,MC}^{i,i,a}}$$

i = ID, a = anti-ID

- Binned in η (only muons) and pT



• Correction to FFs due to different flavour compositions in W+jet and Z+jets.

$$f^W = rac{f^{W,\mathrm{MC}}}{f^{Z,\mathrm{MC}}} imes f^{Z,\mathrm{data}}$$
 21

The MT distribution in 0jet SRs after remapping

	Vgamma	Mis-ID	Z/gamma	gg WW	qq Non-WW	qq WW	ttbar	Wt	ggF	VBF
CR_0j_DF_WW	226.26 ± 30.76	1983.52 ± 39.84	1444.56 ± 58.84	1417.04 ± 4.02	746.86 ± 7.98	14515.54 ± 43.67	2736.49 ± 10.71	1547.18 ± 14.80	303.14 ± 1.92	3.75 ± 0.06
CR_0j_DF_Ztt	2265.89 ± 95.21	2310.59 ± 85.72	134863.84 ± 253.03	101.39 ± 1.07	358.86 ± 3.55	2670.79 ± 18.24	169.82 ± 2.65	84.54 ± 3.44	144.44 ± 1.32	1.51 ± 0.04
CR_0j_DF_top	22.35 ± 9.81	210.43 ± 18.05	150.07 ± 8.92	73.58 ± 0.93	76.42 ± 2.27	534.48 ± 9.28	7229.43 ± 17.14	2097.28 ± 17.05	45.19 ± 0.73	1.24 ± 0.03
SR_0j_DF_Mll1_PtSubLead2_x	172.72 ± 27.97	230.39 ± 11.08	11.78 ± 8.47	90.29 ± 1.00	147.64 ± 3.18	788.17 ± 9.76	111.80 ± 2.12	64.06 ± 2.96	328.93 ± 1.97	3.39 ± 0.06
SR_0j_DF_Mll1_PtSubLead3_x	99.33 ± 21.43	168.40 ± 13.88	24.65 ± 32.29	312.65 ± 1.89	133.17 ± 3.05	1777.97 ± 15.03	272.58 ± 3.41	158.12 ± 4.70	492.66 ± 2.43	6.55 ± 0.08
SR_0j_DF_Mll2_PtSubLead2_x	53.82 ± 14.23	351.26 ± 10.45	35.26 ± 5.81	142.19 ± 1.25	124.03 ± 2.81	1205.93 ± 12.30	216.98 ± 2.97	111.40 ± 3.89	316.29 ± 1.94	3.25 ± 0.05
SR_0j_DF_Mll2_PtSubLead3_x	73.07 ± 29.87	457.54 ± 19.28	40.11 ± 5.72	663.99 ± 2.75	232.17 ± 3.93	4562.96 ± 24.14	700.98 ± 5.46	437.42 ± 7.87	642.11 ± 2.78	8.21 ± 0.09

0-jet Top CR

Before RW

Pt [GeV]

TTbar NNLO RW

Ptl [GeV]

Lead Lep pt RW

Ptt [GeV]

m_T [GeV]

m_T [GeV]

Sample composition(OS Wjet vs Zjets)

Samples		Electron Flavour Composition (%)						
		Bottom	Charm	Strange	Light	Other		
W + jets	ID	1.501 ± 0.379	17.244 ± 1.442	8.162 ± 0.940	66.176 ± 3.338	6.918 ± 0.870		
	Anti-ID	1.501 ± 0.132	26.544 ± 0.622	13.358 ± 0.415	57.403 ± 1.010	1.193 ± 0.115		
Z + jets	ID	21.141 ± 0.693	7.912 ± 0.365	7.483 ± 0.345	54.837 ± 1.139	8.627 ± 0.381		
	Anti-ID	13.734 ± 0.165	12.222 ± 0.140	16.013 ± 0.159	55.991 ± 0.346	2.040 ± 0.053		

Table 19: Sample composition of fake electrons in POWHEG Z + jets and W + jets V21 samples.

Samples		Muon Flavour Composition (%)						
		Bottom	Charm	Strange	Light	Other		
W + jets	ID	7.656 ± 1.243	77.599 ± 5.260	6.400 ± 1.143	5.150 ± 0.966	3.194 ± 0.791		
	Anti-ID	4.905 ± 0.212	84.517 ± 1.167	5.066 ± 0.211	4.658 ± 0.207	0.854 ± 0.089		
Z + jets	ID	58.686 ± 1.717	26.729 ± 0.963	4.329 ± 0.335	4.313 ± 0.333	5.943 ± 0.401		
	Anti-ID	58.951 ± 0.389	31.262 ± 0.238	5.447 ± 0.086	3.586 ± 0.068	0.753 ± 0.031		

Table 20: Sample composition of fake muons in POWHEG Z + jets and W + jets V21 samples.

Correlation plot(ggF0/1)

ATLAS work in progress

MUONS_SAGITTA_RESBIAS	000-0.02 0.00 -0.00-0.02-0.04 0.04 0.00 -0.03-0.02 0.00 0.02 0.02 0.02 0.00 0.00 -0.01-0.01 0.00 -0.01-0.02 0.00 0.01 0.00 0.00-0.02-0.02-0.01-0.02-0.00-0.02-0.00-0.05 0.01 0.08 0.08 -0.03 0.02 0.06		1
EG_RESOLUTION_ALL	0.02 000 0.00 -0.00 0.03 -0.00 0.01 -0.03 -0.04 -0.01 0.01 0.01 0.01 0.00 -0.00 0.01 0.00 0.00		
theo_wt_shower_1j	0.00 -0.00 100 0.02 0.02 -0.01 0.01 0.01 0.01 0.05 0.00 -0.01 0.02 -0.01 0.01 -0.02 0.03 -0.00-0.08 0.03 -0.01 -0.00 0.02 0.00-0.07 -0.00 0.00 0.05 0.03 0.03 -0.05-0.05-0.22 0.15 0.04 -0.10-0.01 -0.03		100.001
theo_wt_matching_0j	0.00 0.00 0.02 100 0.01 0.01 0.00 -0.00 -0.00 0.07 0.01 -0.00 -0.00 -0.01 -0.00 0.00 -0.01 -0.00 0.01 0.00 0.02 0.00 -0.00 0.00 0.00 0.04 -0.00 -0.02 0.03 -0.00 -0.00 -0.01 0.05 0.02 0.00 -0.22 0.02		0.8
JER_EffectiveNP_1_WW	0.02-0.00 0.02 0.01 100-0.02 0.01 0.01 0.00 -0.06-0.00-0.01-0.03 0.01 0.00 -0.02-0.00 0.00 0.00 -0.03-0.00-0.00 0.00 0.0		0.0
JER_EffectiveNP_6	0.04 0.03 -0.01 0.01 -0.02 1000 0.00 -0.00 0.00 -0.01 0.00 0.00 -0.00 0.00		
theo_ggww_scale_1j	<u>0.04 -0</u> .00 0.01 0.00 0.01 0.00 1.00 0.02 -0.02 -0.02 -0.02 -0.01 -0.19 0.00 -0.00 0.01 0.01 0.00 0.03 -0.07 -0.00 -0.00 0.00 -0.03 0.23 -0.00 0.02 0.00 -0.01 -0.10 -0.06 0.02 -0.07 -0.06 -0.01 0.08 0.00 0.08		20.20
theo_ztautau_scale_1j	0.00 0.01 0.01 -0.00 0.01 -0.00 0.00 100 0.02 -0.01 0.00 0.00 0.01 -0.00-0.00-0.00-0.		0.6
MET_SoftTrk_Scale	0.03-0.03 0.00 -0.00 0.00 0.00 0.02 0.02 0.02 100-0.03 0.01 0.01 0.00 0.00 0.00 0.01 0.00 -0.00 0.00		APAS MARK
theo_ww_CSSKIN_0j	0.02-0.04 0.05 0.07 -0.06 -0.01 -0.02 -0.01 -0.03 000 -0.02 0.01 -0.04 0.02 -0.01 -0.00 -0.01 -0.00 -0.01 0.00 -0.00 0.00		
theo_ttbar_shower_0j	0.00 -0.01 0.00 0.01 -0.00 0.00 -0.00 0.00		0.4
theo_ww_scale_0j	0.02 0.01 -0.01-0.00 -0.01 0.00 -0.01 0.00 0.01 0.01		0.4
theo_ww_QSF_1j	0.02 0.01 0.02 -0.00-0.03-0.00-0.19 0.01 0.00 -0.04 -0.00-0.00 000 0.01 0.02 -0.01 0.02 -0.01 0.00 0.04 -0.06 0.00 -0.00-0.00 -0.00 -0.02 -0.07 -0.03 -0.26 0.00 -0.03 -0.17 -0.10 -0.04 0.19 0.01 0.12 0.01 0.12		- SALSSINGS
theo_ww_pdf_0j	0.00 0.00 -0.01 -0.01 0.01 -0.00 0.00 -0.00 0.00		
theo_ggf_QCDscale_ggH	0.00 -0.00 0.01 -0.00 0.00 0.00 -0.00 -0.00 0.00	- 6	02
theo_ggt_shower	0.01 0.01 0.02 0.00 -0.02 -0.01 0.01 -0.00 0.01 -0.00 -0.02 0.02 0.02 0.00 0.00 100 -0.00 0.00 -0.01 0.00 -0.00 -0.01 0.01		0.2
JES_BJES	0.01 0.00 0.03 -0.01 -0.00 0.01 -0.00 0.00 -0.01 0.00 0.02 -0.01 0.00 -0.00 -0.00 -0.00 0.04 0.01 0.00 0.00 -0.00 0.00 -0.00 0.00 -0.00 0.01 -0.00 -0.01 -0.03 -0.11 0.01 0.08 0.01 0.07 0.29 -0.02		
theo_ztautau_pdf_Uj	0.00 0.00 -0.00 0.00 0.00 0.00 0.00 -0.00 -0.00 0.00 0.00 0.00 0.00 -0.00 -0.00 0.00 100 0.00 0.		
JES_Flavor_Comp_top	0.01 0.00 0.08 0.01 0.00 0.02 0.03 0.00 0.00 0.00 0.00 0.04 0.04 0.01 0.01		0
JER_EffectiveNP_1	0.02 0.03 0.03 0.00 -0.03 -0.06 -0.07 0.01 -0.01 0.00 -0.00 -0.00 -0.06 -0.00 0.00 0.01 -0.00 -0.02 100 -0.01 0.00 0.00 -0.030.04 -0.00 -0.02 -0.05 0.01 -0.01 -0.02 -0.13 0.01 0.14 0.16 0.05 0.03 -0.38		×
theo_ttbar_scale_0j	0.00 0.00 -0.01 0.02 -0.00 -0.00 0.00 -0.00 -0.00 0.00		
theo_ztautau_scale_0j	0.01 0.01 0.00 0.00 0.00 0.00 0.00 0.00		
theo_ttoar_scale_1]			-0.2
theo_ww_scale_1			- 5735-331
theo ther matching Oi			
IES PU Rho top			04
JES Flower Comp			-0.4
thee stautou concreter Oi			
theo that matching 1			1.1.1
ET EEE Eigen B 0			-06
norm WW Oiet			0.0
norm WW 1iet			
muGGE	08 001 015 005 003 006 001 011 025 002 001 0 10 03 0 290 29 008 001 0 00 000 00 000 000 00 000 012 012		
norm Ziets Oiet	08 0 3 0 4 0 02 -0 04 -0 09 -0 01 0 04 -0 03 0 02 -0 01 -0 03 -0 04 -0 00 0 00 -0 01 0 01 -0 31 -0 32 0 16 -0 01 -0 44 0 00 -0 000 00 -0 03 -0 01 0 19 0 69 -0 04 0 02 0 12 -0 07 0 30 100 0 09 0 08 -0 32	_	-0.8
norm top 1iet	032 0 2 -0 100 00 0 01 -0 05 0 08 0 02 -0 03 0 03 -0 00-0 02 0 19 -0 000 01 0 01 0 02 -0 00 0 35 0 05 -0 01 -0 00-0 48 -0 020 09 -0 01 0 26 -0 00 0 01 0 01 -0 02 0 02 0 02 -0 01 0 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 26 -0 12 -0 00 0 10 0 0 26 -0 12 -0 00 0 10 0 0 26 -0 12 -0 00 0 0 10 0 0 0 0 0 0 0 0 0 0 0 0 0		
norm top Oiet	012 0 02 0 01 0 22 0 02 0 01 0 02 0 01 0 00 0 01 0 00 0 02 0 25 0 00 0 01 0 00 0 0 0 01 0 28 0 00 0 18 0 03 0 040 0 00 0 01 0 01 0 03 0 18 0 02 0 15 0 11 0 08 0 26 100 0 00		
norm Ziets 1iet			1
	My EC the the Verdenthe the Metho the the the the the the ded denterthe the the the the the the desterthe the FT Des Des Des Des Des Des		-1
	No RESAU TIL FILE BEREDE TO	In Siet	
		let Viet-	ljet
	A REALL SOF WIN THE THE TO OF OF STORE DALL STORE OF STORE OF STORE OF STORE OF STORE OF STORE OF STORE AND STORE AN		
	-G/AS		

Combined fit(2pois)

